1-to-4 Address Register / Driver with 3-state Outputs

HITACHI

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Description

This 1-bit to 4-bit address register / driver is designed for 2.3 V to 3.6 V V_{CC} operation.

The device is ideal for use in applications in which a single address bus is driving four separate memory locations. The HD74ALVCH162832 can be used as a buffer or a register, depending on the logic level of the select (SEL) input.

When \overline{SEL} is a logic high, the device is in the buffer mode. The outputs follow the inputs and are controlled by the two output enable (\overline{OE}) inputs. Each \overline{OE} controls two groups of seven outputs.

When \overline{SEL} is a logic low, the device is in the register mode. The register is an edge triggered D-type flip flop. On the positive transition of the clock (CLK) input, data at the A inputs is stored in the internal registers. \overline{OE} controls operate the same as in the buffer mode.

When \overline{OE} is a logic low, the outputs are in a normal logic state (high or low logic level). When \overline{OE} is a logic high, the outputs are in the high impedance state.

Neither \overline{SEL} nor \overline{OE} affect the internal operation of the flip flops. Old data can be retained or new data can be entered while the outputs are in the high impedance state.

To ensure the high impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current sinking capability of the driver.

Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level. All outputs, which are designed to sink up to 12 mA, include 26 Ω resistors to reduce overshoot and undershoot.

Features

- $V_{CC} = 2.3 \text{ V to } 3.6 \text{ V}$
- Typical V_{OL} ground bounce < 0.8 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- Typical V_{OH} undershoot > 2.0 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- High output current ± 24 mA (@V_{CC} = 3.0 V)
- Bus hold on data inputs eliminates the need for external pullup / pulldown resistors
- All outputs have equivalent 26 Ω series resistors, so no external resistors are required



Function Table

Inputs OE		Output Y		
ŌE	SEL	CLK	Α	
Н	Х	Х	Х	Z
L	Н	X	L	L
L	Н	X	Н	Н
L	L	1	L	L
L	L	<u> </u>	Н	Н

H : High level

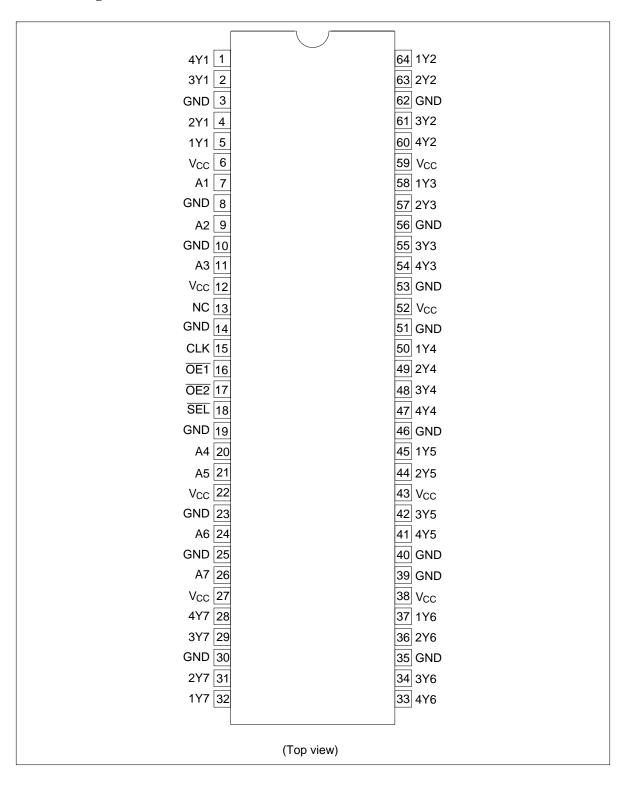
L : Low level

X : Immaterial

Z : High impedance

↑: Low to high transition

Pin Arrangement



Absolute Maximum Ratings

Item	Symbol	Ratings	Unit	Conditions
Supply voltage	V _{cc}	-0.5 to 4.6	V	
Input voltage *1	V _i	-0.5 to 4.6	V	
Output voltage *1, 2	Vo	-0.5 to V_{cc} +0.5	V	
Input clamp current	I _{IK}	-50	mA	V ₁ < 0
Output clamp current	I _{ok}	±50	mA	V_{o} < 0 or V_{o} > V_{cc}
Continuous output current	Io	±50	mA	$V_0 = 0$ to V_{CC}
V _{cc} , GND current / pin	I _{CC} or I _{GND}	±100	mA	
Maximum power dissipation at Ta = 55°C (in still air) ^{'3}	P _T	1	W	TSSOP
Storage temperature	T _{stg}	-65 to 150	°C	

Notes:

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rated conditions for extended periods may affect device reliability.

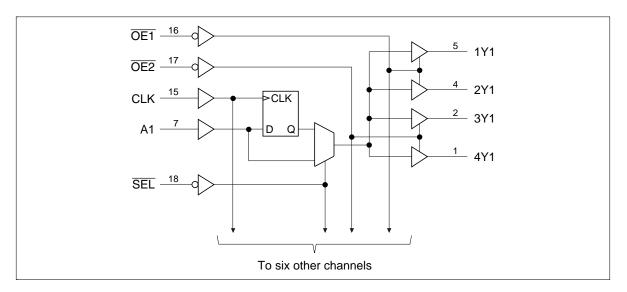
- 1. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
- 2. This value is limited to 4.6 V maximum.
- 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

Recommended Operating Conditions

Item	Symbol	Min	Max	Unit	Conditions
Supply voltage	V _{cc}	2.3	3.6	V	
Input voltage	V _I	0	V _{cc}	V	
Output voltage	V _o	0	V _{cc}	V	
High level output current	I _{OH}	_	-6	mA	V _{CC} = 2.3 V
		_	-8		V _{CC} = 2.7 V
		_	-12		$V_{cc} = 3.0 \text{ V}$
Low level output current	I _{OL}	_	6	mA	V _{cc} = 2.3 V
		_	8		V _{CC} = 2.7 V
		_	12		$V_{CC} = 3.0 \text{ V}$
Input transition rise or fall rate	Δt / Δν	0	10	ns / V	
Operating temperature	T _a	-40	85	°C	

Note: Unused control inputs must be held high or low to prevent them from floating.

Logic Diagram



Electrical Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Item	Symbol	V _{cc} (V) *1	Min	Max	Unit	Test Conditions
Input voltage	V _{IH}	2.3 to 2.7	1.7	_	V	
		2.7 to 3.6	2.0	_	_	
	V _{IL}	2.3 to 2.7	_	0.7		
		2.7 to 3.6	_	0.8	_	
Output voltage	V _{OH}	2.3 to 3.6	V _{cc} -0.2	_	V	$I_{OH} = -100 \mu A$
		2.3	1.9	_	_	$I_{OH} = -4 \text{ mA}, V_{IH} = 1.7 \text{ V}$
		2.3	1.7	_		$I_{OH} = -6 \text{ mA}, V_{IH} = 1.7 \text{ V}$
		2.7	2.0	_		$I_{OH} = -8 \text{ mA}, V_{IH} = 2.0 \text{ V}$
		3.0	2.4	_		$I_{OH} = -6 \text{ mA}, V_{IH} = 2.0 \text{ V}$
		3.0	2.0	_		$I_{OH} = -12 \text{ mA}, V_{IH} = 2.0 \text{ V}$
	V _{OL}	2.3 to 3.6	_	0.2		I _{OL} = 100 μA
		2.3	_	0.4		$I_{OL} = 4 \text{ mA}, V_{IL} = 0.7 \text{ V}$
		2.3	_	0.55		$I_{OL} = 6 \text{ mA}, V_{IL} = 0.7 \text{ V}$
		2.7		0.6	_	$I_{OL} = 8 \text{ mA}, V_{IL} = 0.8 \text{ V}$
		3.0	_	0.55		$I_{OL} = 6 \text{ mA}, V_{IL} = 0.8 \text{ V}$
		3.0	_	0.8		$I_{OL} = 12 \text{ mA}, V_{IL} = 0.8 \text{ V}$
Input current	I _{IN}	3.6	_	±5	μΑ	$V_{IN} = V_{CC}$ or GND
	I _{IN (hold)}	2.3	45	_		$V_{IN} = 0.7 \text{ V}$
		2.3	-45			V _{IN} = 1.7 V
		3.0	75	_		V _{IN} = 0.8 V
		3.0	- 75	_		V _{IN} = 2.0 V
		3.6		±500		$V_{IN} = 0 \text{ to } 3.6 \text{ V}^{*2}$
Off state output current	l _{oz}	3.6	_	±10	μΑ	$V_{OUT} = V_{CC}$ or GND
Quiescent supply current	: I _{cc}	3.6	_	40	μΑ	$V_{IN} = V_{CC}$ or GND
	ΔI_{CC}	3.0 to 3.6	_	750	μΑ	V_{IN} = one input at (V_{CC} -0.6) V, other inputs at V_{CC} or GND

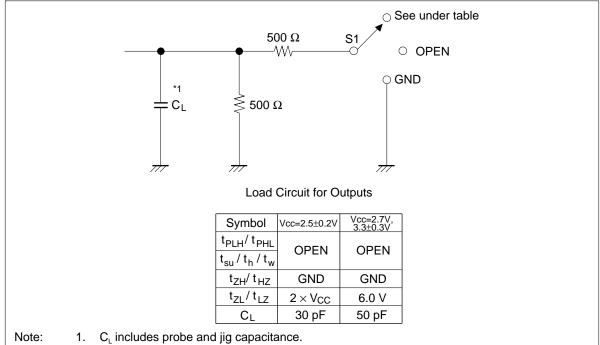
Notes: 1. For conditions shown as Min or Max, use the appropriate values under recommended operating conditions.

^{2.} This is the bus hold maximum dynamic current required to switch the input from one state to another.

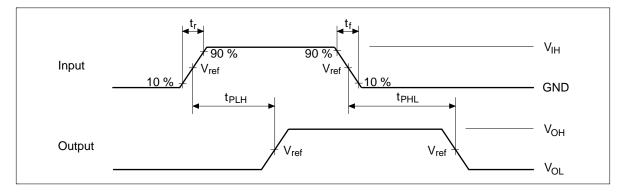
Switching Characteristics ($Ta = -40 \text{ to } 85^{\circ}\text{C}$)

Item	Symbol	V _{cc} (V)	Min	Тур	Max	Unit	FROM (Input)	TO (Output)
Maximum clock frequenc	f _{max}	2.5±0.2	150	_	_	MHz		
		2.7	150	_	_			
		3.3±0.3	150	_				
Propagation delay time	t _{PLH}	2.5±0.2	1.1	_	4.7	ns	Α	Υ
	$t_{\tiny PHL}$	2.7	_	_	4.8			
		3.3±0.3	1.5	_	4.3			
		2.5±0.2	1.0	_	5.3		CLK	Υ
		2.7	_	_	5.3			
		3.3±0.3	1.4		4.7	_		
		2.5±0.2	1.1	_	6.0	_	SEL	Υ
		2.7	_	_	6.2			
		3.3±0.3	1.5		4.8	_		
Output enable time	t _{zH}	2.5±0.2	1.0		5.9	ns	ŌĒ	Υ
	$\mathbf{t}_{\scriptscriptstyle ZL}$	2.7		_	5.9			
		3.3±0.3	1.1		5.1	_		
Output disable time	t _{HZ}	2.5±0.2	1.4		6.3	ns	ŌĒ	Υ
	t_{LZ}	2.7	_		5.4			
		3.3±0.3	1.6		5.1			
Setup time	t _{su}	2.5±0.2	2.0			ns	-11	"
		2.7	2.0					
		3.3±0.3	1.6	_				
Hold time	t _h	2.5±0.2	0.7	_		ns		"
		2.7	0.5					
		3.3±0.3	1.1	_	_			
Pulse width	t _w	2.5±0.2	3.3	_		ns	-11	
		2.7	3.3					
		3.3±0.3	3.3	_	_			
Input capacitance	C _{IN}	3.3	_	4.5		pF	Control in	nputs
		3.3	_	5.0		_	Data inpu	ıts
Output capacitance	C _o	3.3	_	7.5	_	pF	Outputs	

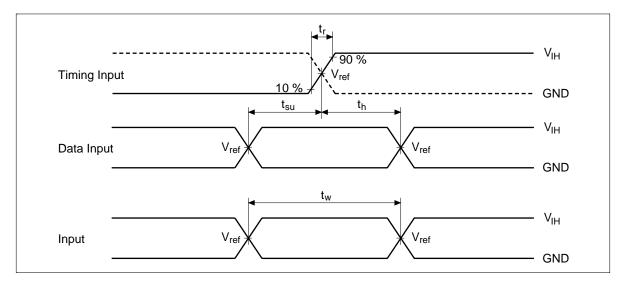
Test Circuit



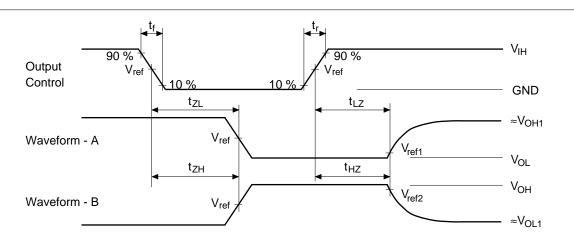
Waveforms - 1



Waveforms - 2



Waveforms - 3



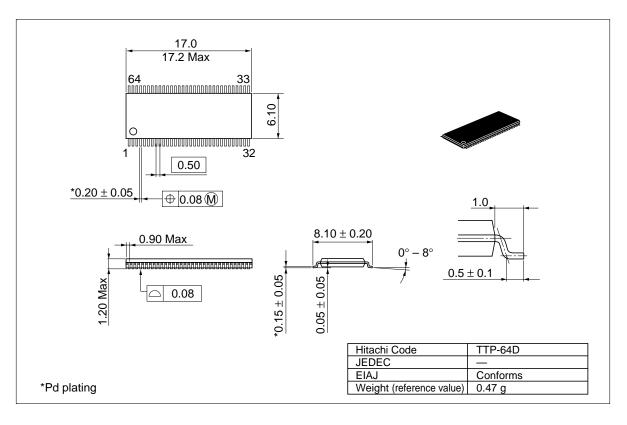
TEST	Vcc=2.5±0.2V	Vcc=2.7V, 3.3±0.3V		
V_{IH}	V _{CC}	2.7 V		
V_{ref}	1/2 V _{CC}	1.5 V		
V _{ref1}	V _{OL} +0.15 V	V _{OL} +0.3 V		
V_{ref2}	V _{OH} -0.15 V	V _{OH} -0.3 V		
V_{OH1}	V _{CC}	3.0 V		
V_{OL1}	GND	GND		

Notes:

- 1. All input pulses are supplied by generators having the following characteristics : PRR \leq 10 MHz, Zo = 50 Ω , $t_{_{f}} \leq$ 2.0 ns, $t_{_{f}} \leq$ 2.0 ns. (V $_{\text{CC}}$ = 2.5±0.2 V) PRR \leq 10 MHz, Zo = 50 Ω , $t_{_{f}} \leq$ 2.5 ns, $t_{_{f}} \leq$ 2.5 ns. (V $_{\text{CC}}$ = 2.7 V, 3.3±0.3 V)
- 2. Waveform A is for an output with internal conditions such that the output is low except when disabled by the output control.
- 3. Waveform B is for an output with internal conditions such that the output is high except when disabled by the output control.
- 4. The output are measured one at a time with one transition per measurement.

Package Dimensions

Unit: mm



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IITACHI

Hitachi, Ltd.

Semiconductor & Integrated Circuits. Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan

Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

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For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose,CA 95134 Tel: <1> (408) 433-1990 Germany Fax: <1>(408) 433-0223

Hitachi Europe GmbH Electronic Components Group Dornacher Stra§e 3 D-85622 Feldkirchen, Munich

Tel: <49> (89) 9 9180-0 Fax: <49> (89) 9 29 30 00

Hitachi Europe Ltd. Electronic Components Group. Whitebrook Park Lower Cookham Road

Maidenhead Berkshire SL6 8YA, United Kingdom Tel: <44> (1628) 585000 Fax: <44> (1628) 585160

Hitachi Asia Ltd. Hitachi Tower 16 Collyer Quay #20-00, Singapore 049318 Tel: <65>-538-6533/538-8577 Fax: <65>-538-6933/538-3877 URL: http://www.hitachi.com.sg

Hitachi Asia Ltd (Taipei Branch Office) 4/F, No. 167, Tun Hwa North Road,

Huna-Kuo Buildina. Taipei (105), Taiwan Tel: <886>-(2)-2718-3666 Fax: <886>-(2)-2718-8180

Telex: 23222 HAS-TP URL: http://www.hitachi.com.tw Group III (Electronic Components) 7/F., North Tower, World Finance Centre, Harbour City, Canton Road Tsim Sha Tsui, Kowloon, Hong Kong

Hitachi Asia (Hong Kong) Ltd.

Tel: <852>-(2)-735-9218 Fax: <852>-(2)-730-0281 URL: http://www.hitachi.com.hk

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